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ABSTRACT

We report ultra-narrow-linewidth erbium-doped aluminum oxide (Al2O3:Er3+) distributed feedback (DFB) lasers with a wavelength-insensitive silicon-compatible waveguide design. The waveguide consists of five silicon nitride (SiN_x) segments buried under silicon dioxide (SiO_2) with a layer Al2O3:Er3+ deposited on top. This design has a high confinement factor (> 85%) and a near perfect (> 98%) intensity overlap for an octave-spanning range across near infrared wavelengths (950–2000 nm). We compare the performance of DFB lasers in discrete quarter phase shifted (QPS) cavity and distributed phase shifted (DPS) cavity. Using QPS-DFB configuration, we obtain maximum output powers of 0.41 mW, 0.76 mW, and 0.47 mW at widely spaced wavelengths within both the C and L bands of the erbium gain spectrum (1536 nm, 1566 nm, and 1596 nm). In a DPS cavity, we achieve an order of magnitude improvement in maximum output power (5.43 mW) and a side mode suppression ratio (SMSR) of > 59.4 dB at an emission wavelength of 1565 nm. We observe an ultra-narrow linewidth of \( \Delta \nu_{\text{DPS}} = 5.3 \pm 0.3 \text{ kHz} \) for the DPS-DFB laser, as compared to \( \Delta \nu_{\text{QPS}} = 30.4 \pm 1.1 \text{ kHz} \) for the QPS-DFB laser, measured by a recirculating self-heterodyne delayed interferometer (R-SHDI). Even narrower linewidth can be achieved by mechanical stabilization of the setup, increasing the pump absorption efficiency, increasing the output power, or enhancing the cavity Q.

Keywords: Erbium, lasers, silicon photonics, integrated optics, rare-earth-ion-doped devices.

1. INTRODUCTION

Integration of high quality ultra-narrow-linewidth lasers on a silicon photonics platform is important for several applications, including digital coherent communications, coherent Lidar, optical metrology, and sensing [1]. Hybrid III-V silicon lasers have been shown to generate several MHz optical linewidth with phase-shifted distributed feedback (DFB) cavities [2]. To obtain a kHz linewidth laser, an external cavity can be constructed by combining the semiconductor gain medium with a Vernier-based tunable filter [3] or a high Q resonance cavity can be used with low passive loss [4]. However, these approaches generally require complex fabrication steps, or careful temperature control. Alternatively, monolithic erbium-doped aluminum oxide (Al2O3:Er3+) lasers have been shown to achieve linewidths as low as 1.7 kHz using a DFB cavity [5]. Recently, we have demonstrated a CMOS-compatible design to integrate Al2O3:Er3+ lasers in a wafer-scale process with a single backend step [6, 7]. The waveguide consists of a thin (~100 nm) silicon nitride (SiN_x) structure buried in a silicon dioxide (SiO_2) layer to achieve high confinement factor and mode overlap in the gain film [7-9].

In this paper, we extend the design to work for a thicker silicon nitride by using a multi-segmented waveguide structure [10-14]. This allows integration into a more general silicon photonics wafer-scale process where thicker, higher-confinement SiN_x structures might be preferred [15-17]. We compare the performance of DFB lasers in discrete quarter phase shifted (QPS) cavities and distributed phase shifted (DPS) cavities [5, 18]. By using a QPS-DFB...
configuration, we obtain single frequency lasing at 1536 nm, 1566 nm, and 1596 nm with on-chip output powers of 0.41 mW, 0.76 mW, and 0.47 mW respectively. This spans a similar emission bandwidth that has been shown previously in distributed Bragg reflector (DBR) lasers [7], covering the C and L band of the erbium gain spectrum. In a DPS cavity, we achieve an order of magnitude improvement in maximum output power (5.43 mW) for a wavelength centered at 1565 nm, corresponding to side mode suppression ratio (SMSR) of > 59.4 dB. Using a recirculating self-heterodyne delayed interferometer (R-SHDI) [19, 20], we also observe a narrower linewidth for DPS-DFB at ΔνDPS = 5.3 ± 0.3 kHz, as compared to QPS-DFB at ΔνQPS = 30.4 ± 1.1 kHz. The improvement can be explained by reduction of spatial hole burning in the center of cavity and increased effective gain section [21, 22].

2. GAIN WAVEGUIDE DESIGN

![Fig. 1. (a) Schematic of wavelength-insensitive laser waveguide design by multi-segmented SiNₓ structure. (b) Mode-solver calculation of the intensity distribution for various near infrared wavelengths in the multi-segmented waveguide design.](image)

Figure 1(a) shows a schematic of the wavelength insensitive waveguide design. It consists of a silicon (Si) substrate, five SiNₓ segments (thickness t of 200 nm, width w of 450 nm, and gap g of 400 nm), enclosed by a SiO₂ layer (oxide gap gox of 200 nm), and Al₂O₃:Er³⁺ gain film (thickness tAlO = 1100 nm). The fabrication process has been reported in references [7, 23] with the only difference in the layer thickness or dopant. The distance between the Si to the bottom layer of SiNₓ (>2.5 μm) is sufficient to ensure the fundamental TE mode is not affected by the substrate. We use the prism coupling method to estimate the Al₂O₃:Er³⁺ gain film background loss of <0.1 dB/cm and dopant concentration of 1.0×10²⁰ cm⁻³.

3. Al₂O₃:Er³⁺ DFB LASERS

We apply the five-segment wavelength-insensitive design to realize single-frequency and ultra-narrow-linewidth Al₂O₃:Er³⁺ lasers. We investigate two different phase shift configurations for 2 cm long DFB cavity. In QPS-DFB, a discrete quarter phase shift is formed at the center of the cavity with a sharp frequency resonance at the Bragg wavelength. The intense electric field concentrated around the phase shifted region may limit the performance of the laser due to spatial hole burning [24, 25]. Alternatively, the phase shift in DPS-DFB cavity is continuously distributed in a wider region, thus improving the uniformity of the field distribution and increasing the length of the effective gain section. We compare the performance of the lasers in the following sections.

3.1 QPS-DFB

The grating unit in the QPS-DFB cavities is formed by placing additional periodic pieces on both sides of the five-segment SiNₓ structure, as shown in Fig. 2(a). These periodic side pieces have width wg of 300 nm with the grating strength κ adjusted by varying the gap distance deg. We fabricated a total of 9 devices with 3 grating period variations (Λ = 482 nm, 492 nm, and 502 nm) and 3 grating strength variations (deg / κ = 600 nm / 0.6 mm⁻¹, 350 nm / 0.9 mm⁻¹, and 200 nm / 1.2 mm⁻¹).

To characterize their performance, we pumped the DFB lasers from both sides using fiber pigtail laser diodes at 978 nm and 976 nm. We obtain the best laser performance from devices with deg / κ = 350 nm or κ = 0.9 mm⁻¹ for all three wavelengths. Figure 2(b) shows the spectra of DFB lasers operating at 1536 nm, 1566 nm, and 1596 nm, which covers a similar emission bandwidth that has been shown previously in distributed Bragg reflector (DBR) lasers [7]. The highest on-chip output power of 0.76 mW is achieved at 1566 nm. The laser operating at 1536 nm has the lowest output power,
corresponding to > 46.1 dB side mode suppression ratio (SMSR) for all devices. We characterize the slope efficiency and threshold power of the lasers, as shown in Fig. 2(c). We obtain slope efficiencies $\eta = 0.3\%, 0.6\%$, and $0.3\%$ and threshold powers $P_{th} = 55\ mW, 65\ mW,$ and $105\ mW$ for lasers at wavelengths $1536\ nm, 1566\ nm,$ and $1596\ nm,$ respectively.

The thermal stability of our DFB is investigated in [26, 27] showing a temperature-dependent shift of $0.02\ nm/^\circ C$, which is more than two times lower than the thermal wavelength shift reported for hybrid lasers [28-31]. Such small wavelength shift is contributed by the low thermo-optic coefficients of the Al$_2$O$_3$ film and the Si$_N_x$ waveguide. The laser stability over time is mainly affected by mechanical misalignment of the fiber coupling for pump and lasing signal. A short term solution is to isolate the laser chip by covering up the test setup, so that the coupling fiber will be minimally affected by environmental fluctuations. Meanwhile, a long term solution is to integrate the diode pump onto the system so that fiber coupling is not necessary.

3.2 DPS-DFB

The DPS-DFB cavities are formed using an asymmetric design which includes a continuous segment with varying width $w_\alpha(x)$ on one side of the waveguide and periodic pieces with spacing $d(x)$ on the other side, where $x$ is the axis along the cavity, as shown in Fig. 3(a). This allows accumulation of phase shift by a gradual sinusoidal change of the effective refractive index $\Delta n_{eff}(x)$ [18] while maintaining a constant grating strength $\kappa$ in the phase shifted region with length $L_{ps}$. We use the coupled mode theory [32-34] to determine the right combination of $w_\alpha(x)$ and $d(x)$ for fixed gap distance $d_0 = 250\ nm$ and periodic pieces of width $w_\kappa = 300\ nm$. We fabricated two different $L_{ps}$ (0.2 cm and 0.4 cm) for grating period at $492\ nm$ and $\kappa = 0.7\ mm^{-1}$. For the 0.2-cm DPS-DFB, $w_\alpha(x)$ varies from 168-351 nm and $d(x)$ varies from 119-162 nm. For the 0.4-cm DPS-DFB, $w_\alpha(x)$ varies from 168-271 nm and $d(x)$ varies from 140-162 nm.

Figure 3(b) shows the spectrum of the best DPS-DFB with $L_{ps} = 0.4\ cm$ and emission centered at $\lambda = 1565\ nm$. A maximum on-chip output power of 5.43 mW is obtained, corresponding to a SMSR > 59.4 dB. Figure 3(c) shows the comparison of power performance of the lasers. The longer $L_{ps}$ DPS-DFB laser has almost double the output power at maximum pump. The threshold power is > 4 times lower than the QPS design ($P_{th} = 14\ mW$), with close to 5 times improvement in the slope efficiency ($\eta = 2.9\%$). These improvements can be attributed to a more uniform and longer active gain section in DPS-DFB. Meanwhile, compare with QPS structure, DPS structure may have slightly higher loss from (a) the asymmetry of the grating (due to transition from symmetric waveguide to asymmetric design), and (b) the
Fig. 3. (a) Design of Al₂O₃:Er³⁺ DPS-DFB laser with five-segment SiNₓ waveguide (not to scale). The cavity structure consists of five continuous SiNₓ segments with grating perturbation provided by two additional side pieces, one with a phase shift region (top) and the other with periodic segments (bottom). (b) Optical spectrum of Al₂O₃:Er³⁺ DPS-DFB lasers at various grating periods. (c) On-chip laser power of Al₂O₃:Er³⁺ DPS-DFB lasers vs. pump power.

4. ULTRA-NARROW-LINEWIDTH MEASUREMENT

For an accurate linewidth measurement in a self-heterodyne interferometer, a fiber delay length larger than the laser coherence length is required \( L_{\text{delay}} > L_{\text{coherence}} \) [35, 36]. From the Schawlow-Townes formula, the fundamental (quantum) linewidth limit of an Al₂O₃:Er³⁺ DFB laser can reach the sub-kHz level [37]. If we assume \( \Delta \nu = 1 \text{ kHz} \) and the speed of light \( c/n = 2 \times 10^8 \text{ m/s} \), then the minimum \( L_{\text{delay}} \) needs to be at least 200 km. Such a long fiber requirement can be alleviated in a recirculating SHDI (R-SHDI) configuration [19, 20]. The setup is similar to a standard SHDI, but one of the branches couples to a multipass cavity that consists of a fiber delay and an acousto optic modulator (AOM) for frequency shifting \( f_{\text{AOM}} = 44 \text{ MHz} \). Thus, the spectrum at frequency \( n \times f_{\text{AOM}} \) corresponds to an auto-correlation of the input light after passing through the equivalent delay of \( n \times L_{\text{delay}} \). Lastly, an erbium doped fiber amplifier (EDFA), an optical isolator, and a tunable filter are included to compensate for roundtrip loss.

Fig. 4. Recirculating self-heterodyne delayed interferometer for ultra-narrow linewidth measurement.
We measured the linewidth of the Al2O3:Er3+ QPS-DFB laser centered at λ = 1566 nm and DPS-DFB laser centered at λ = 1565 nm, as shown in Fig. 5. For QPS-DFB laser, the spectrum was collected at a center frequency of \( f_c = 132 \text{ MHz} \) \((n = 3)\), which corresponds to a total delay length of \( L_{\text{delay}} = 105 \text{ km} \). For the DPS-DFB laser, \( n = 15, \ f_c = 660 \text{ MHz}, \) and the effective \( L_{\text{delay}} = 525 \text{ km} \). To differentiate the 1/f frequency noise contribution, the measured spectra are fitted with Voigt functions [38, 39]. The self-heterodyne spectra are plotted around \( f_c \) with the QPS-DFB laser presented in red color and the DPS-DFB laser in blue color.

By fitting the QPS-DFB spectrum, we obtain a full width half maximum (FWHM) of the Voigt function of \( \text{FWHM}_{\text{Voigt}} = 66.1 \pm 2.5 \text{ kHz} \). The Voigt linewidth is further decomposed into the Gaussian component \( \text{FWHM}_{\text{Gauss}} = 18.4 \pm 7.9 \text{ kHz} \) and Lorentzian component \( \text{FWHM}_{\text{Lorentz}} = 60.7 \pm 2.2 \text{ kHz} \). As the self-heterodyne measurement is an autocorrelation process whose FWHM is 2 times the laser linewidth, the optical linewidth \( \Delta \nu \) can be estimated from half the Lorentzian width of the spectrum, thus \( \Delta \nu_{\text{QPS}} = \frac{1}{2} \times \text{FWHM}_{\text{Lorentz}} = 30.4 \pm 1.1 \text{ kHz} \). For the DPS-DFB laser, with the same analysis above we obtain \( \text{FWHM}_{\text{Voigt}} = 23.8 \pm 0.7 \text{ kHz}, \text{FWHM}_{\text{Gauss}} = 17.5 \pm 1 \text{ kHz}, \text{FWHM}_{\text{Lorentz}} = 10.5 \pm 0.5 \text{ kHz} \), and thus \( \Delta \nu_{\text{DPS}} = 5.3 \pm 0.3 \text{ kHz} \). The linewidth improvement in the DPS-DFB laser \( (\Delta \nu_{\text{QPS}} = 5.73 \times \Delta \nu_{\text{DPS}}) \) can be attributed to a higher output power and reduction in the spatial hole burning effect.

To our knowledge, this is one of the first demonstrations of a sub-10-kHz-linewidth monolithically integrated laser in a CMOS-compatible silicon photonics platform [2, 3, 5]. The lowest linewidth for an erbium-doped Al2O3:Er3+ DFB waveguide laser was obtained in [5]. The linewidth difference between our laser and the ultra-narrow-linewidth laser reported in ref. [5] might be explained by differences in the waveguide and cavity dimensions, the wavelength and linewidth quality of the pump laser and/or the mechanical and environmental stability of the experiment. By careful optimization each of these properties we expect that further reduction of the linewidth can be obtained.

**Fig. 5.** Self-heterodyne spectra of Al2O3:Er3+ QPS- (red) and DPS- (blue) DFB lasers in (a) linear and (b) dB scale. The solid lines of the same color are the fits of the corresponding measurements (dots).

### 5. CONCLUSION

In summary, we demonstrate narrow linewidth Al2O3:Er3+ DFB lasers using a multi-segmented SiNx silicon-compatible waveguide design. We apply the design to QPS-DFB and DPS-DFB cavities. In the QPS-DFB configuration, we obtain maximum output powers of 0.41 mW, 0.76 mW, and 0.47 mW at widely spaced wavelengths within both the C and L bands of the erbium gain spectrum (1536 nm, 1566 nm, and 1596 nm). In a DPS cavity, we achieve an order of magnitude improvement in maximum output power (5.43 mW) for a wavelength centered at 1565 nm, corresponding to a side mode suppression ratio (SMSR) of > 59.4 dB. Finally, we measure the optical linewidths with an R-SHDI setup to obtain \( \Delta \nu_{\text{QPS}} = 30.4 \pm 1.1 \text{ kHz} \) and \( \Delta \nu_{\text{DPS}} = 5.3 \pm 0.3 \text{ kHz} \). The overall improvement of the DPS-DFB cavity can be attributed to the reduction of spatial hole burning in DPS-DFB cavity and a longer effective gain section. Even narrower linewidth can be achieved by mechanical stabilization of the setup, increasing the pump absorption efficiency, increasing the output power, or enhancing the cavity Q. The Q can be enhanced by accounting for Al2O3:Er3+ film thickness variation across the cavity, reducing the SiNx loss and optimizing the DFB grating strength.

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